

N-Channel 250-V (D-S) 175°C MOSFET

PRODUCT SUMMARY

$V_{(BR)DSS}$ (V)	$r_{DS(on)}$ (Ω)	I_D (A)	Q_g (Typ)
250	0.060 @ $V_{GS} = 10$ V	40	95
	0.064 @ $V_{GS} = 6$ V	38.7	

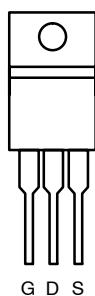
FEATURES

- TrenchFET® Power MOSFETs
- 175°C Junction Temperature
- New Low Thermal Resistance Package

APPLICATIONS

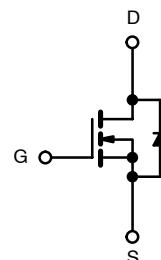
- Industrial

TO-220AB



Top View

Ordering Information: SUP40N25-60—E3



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	250	
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current ($T_J = 175^\circ\text{C}$)	I_D	40	A
		23	
Pulsed Drain Current	I_{DM}	70	
Avalanche Current	I_{AR}	35	
Repetitive Avalanche Energy ^a	E_{AR}	61	mJ
Maximum Power Dissipation ^a	P_D	300 ^b	W
		3.75	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	-55 to 175	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Limit	Unit
Junction-to-Ambient (PCB Mount) ^c	R_{thJA}	40	
Junction-to-Case (Drain)	R_{thJC}	0.5	°C/W

Notes

- Duty cycle $\leq 1\%$.
- See SOA curve for voltage derating.
- When mounted on 1" square PCB (FR-4 material).

**SPECIFICATIONS ($T_J = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)**

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{DS}} = 0 \text{ V}, I_D = 250 \mu\text{A}$	250			V
Gate-Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250 \mu\text{A}$	2		4	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0 \text{ V}, V_{\text{GS}} = \pm 30 \text{ V}$			± 250	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 250 \text{ V}, V_{\text{GS}} = 0 \text{ V}$			1	
		$V_{\text{DS}} = 250 \text{ V}, V_{\text{GS}} = 0 \text{ V}, T_J = 125^\circ\text{C}$			50	
		$V_{\text{DS}} = 250 \text{ V}, V_{\text{GS}} = 0 \text{ V}, T_J = 175^\circ\text{C}$			250	
On-State Drain Current ^a	$I_{\text{D}(\text{on})}$	$V_{\text{DS}} \geq 5 \text{ V}, V_{\text{GS}} = 10 \text{ V}$	70			A
Drain-Source On-State Resistance ^a	$r_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10 \text{ V}, I_D = 20 \text{ A}$		0.049	0.060	
		$V_{\text{GS}} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 125^\circ\text{C}$			0.121	
		$V_{\text{GS}} = 10 \text{ V}, I_D = 20 \text{ A}, T_J = 175^\circ\text{C}$			0.163	
		$V_{\text{GS}} = 6 \text{ V}, I_D = 15 \text{ A}$		0.051	0.064	
Forward Transconductance ^a	g_{fs}	$V_{\text{DS}} = 15 \text{ V}, I_D = 20 \text{ A}$		70		S
Dynamic^b						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0 \text{ V}, V_{\text{DS}} = 25 \text{ V}, f = 1 \text{ MHz}$		5000		
Output Capacitance	C_{oss}			300		
Reverse Transfer Capacitance	C_{rss}			170		pF
Total Gate Charge ^c	Q_g	$V_{\text{DS}} = 125 \text{ V}, V_{\text{GS}} = 10 \text{ V}, I_D = 45 \text{ A}$		95	140	
Gate-Source Charge ^c	Q_{gs}			28		nC
Gate-Drain Charge ^c	Q_{gd}			34		
Gate Resistance	R_g		$f = 1 \text{ MHz}$	1.6		Ω
Turn-On Delay Time ^c	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 100 \text{ V}, R_L = 2.78 \Omega$ $I_D \approx 45 \text{ A}, V_{\text{GEN}} = 10 \text{ V}, R_g = 2.5 \Omega$		22	35	
Rise Time ^c	t_r			220	330	
Turn-Off Delay Time ^c	$t_{\text{d}(\text{off})}$			40	60	
Fall Time ^c	t_f			145	220	ns
Source-Drain Diode Ratings and Characteristics ($T_C = 25^\circ\text{C}$)^b						
Continuous Current	I_S				45	
Pulsed Current	I_{SM}				70	A
Forward Voltage ^a	V_{SD}	$I_F = 45 \text{ A}, V_{\text{GS}} = 0 \text{ V}$		1.0	1.5	V
Reverse Recovery Time	t_{rr}	$I_F = 45 \text{ A}, \text{di/dt} = 100 \text{ A}/\mu\text{s}$		150	225	ns
Peak Reverse Recovery Current	$I_{\text{RM}(\text{REC})}$			12	18	A
Reverse Recovery Charge	Q_{rr}			0.9	2	μC

Notes

- a. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.